

Application No.	Applicant(s)	
10/076,154	HINO ET AL.	
Examiner	Art Unit	
TAN N TRAN	2826	

SEARCHED				
Class	Subclass	Date	Examiner	
257	774	03/84	11	
	207			
	268			
	211			
	758			
	773	J/	V	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>	<sub></sub>	.,.		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	33/om	+1		
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